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April 1988 Revised October 2000

#### 74F573

## **Octal D-Type Latch with 3-STATE Outputs**

#### **General Description**

The 74F573 is a high speed octal latch with buffered common Latch Enable (LE) and buffered common Output Enable  $(\overline{OE})$  inputs.

This device is functionally identical to the 74F373 but has different pinouts.

#### **Features**

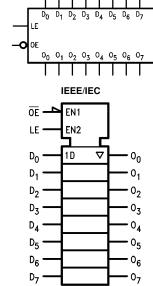
- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to 74F373
- 3-STATE outputs for bus interfacing
- Guaranteed 4000V minimum ESD protection

#### **Ordering Code:**

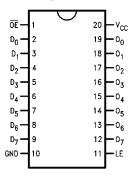
Order Number	Package Number	Package Description
74F573SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F573SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F573PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### **Logic Symbols**



## **Connection Diagram**



### **Unit Loading/Fan Out**

Pin Names	December 1	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>	
	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>	
D <sub>0</sub> –D <sub>7</sub>	Data Inputs	1.0/1.0	20 μA/-0.6 mA	
LE	Latch Enable Input (Active HIGH)	1.0/1.0	20 μA/-0.6 mA	
ŌĒ	3-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/–0.6 mA	
O <sub>0</sub> -O <sub>7</sub>	3-STATE Latch Outputs	150/40(33.3)	-3 mA/24 mA (20 mA)	

#### **Functional Description**

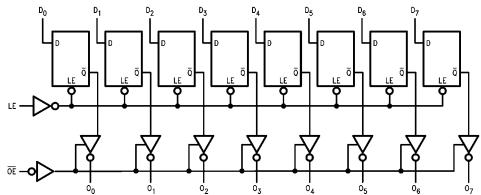
The 74F573 contains eight D-type latches with 3-state output buffers. When the Latch Enable (LE) input is HIGH, data on the  $\mathsf{D}_n$  inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The 3-state buffers are controlled by the Output Enable  $(\overline{\mathsf{OE}})$  input. When  $\overline{\mathsf{OE}}$  is LOW, the buffers are in the bi-state mode. When  $\overline{\mathsf{OE}}$  is HIGH the buffers are in the high impedance mode but this does not interfere with entering new data into the latches.

#### **Function Table**

	Outputs		
OE	LE	D	0
L	Н	Н	Н
L	Н	L	L
L	L	Χ	O <sub>0</sub>
Н	X	Χ	O <sub>0</sub> Z

H = HIGH Voltage Level

#### **Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

L = LOW Voltage Level

X = Immaterial

O<sub>0</sub> = Value stored from previous clock cycle

### **Absolute Maximum Ratings**(Note 1)

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$ 

Junction Temperature under Bias -55°C to +150°C V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V

Voltage Applied to Output

in HIGH State (with  $V_{CC}$  = 0V) Standard Output -0.5V to  $V_{CC}$  3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max)  ${\rm twice\ the\ rated\ I_{OL}\ (mA)}$  ESD Last Passing Voltage (Min)  ${\rm 4000V}$ 

# **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

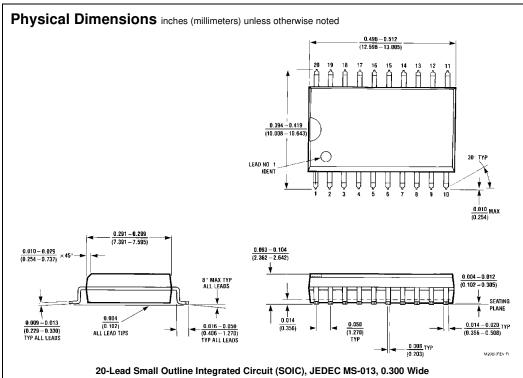
Symbol	Parameter		Min	Тур	Max	Units	v <sub>cc</sub>	Conditions	
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA	
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5					I <sub>OH</sub> = -1 mA	
	Voltage	10% V <sub>CC</sub>	2.4			V	Min	$I_{OH} = -3 \text{ mA}$	
		5% V <sub>CC</sub>	2.7			V	IVIIII	$I_{OH} = -1 \text{ mA}$	
		5% V <sub>CC</sub>	2.7					$I_{OH} = -3 \text{ mA}$	
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.5	V	Min	1 - 24 mA	
	Voltage				0.5	V	IVIIN	I <sub>OL</sub> = 24 mA	
I <sub>IH</sub>	Input HIGH				20.0	μА	Max	V <sub>IN</sub> = 2.7V	
	Current				5.0	μΑ	iviax	v <sub>IN</sub> = 2.7 v	
I <sub>BVI</sub>	Input HIGH Current				7.0	^	Max	V <sub>IN</sub> = 7.0V	
	Breakdown Test				7.0	μА	iviax	v <sub>IN</sub> = 7.0 v	
I <sub>CEX</sub>	Output HIGH				50	μА	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
	Leakage Current				30	μΛ	IVIAX	VOUT - VCC	
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9  \mu A$	
	Test		4.75			V	0.0	All Other Pins Grounded	
l <sub>OD</sub>	Output Leakage				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV	
	Circuit Current				3.73	μΑ	0.0	All Other Pins Grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
l <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V	
l <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V	
los	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>ZZ</sub>	Bus Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V	
I <sub>CCL</sub>	Power Supply Current			35	55	mA	Max	$V_O = LOW$	
I <sub>CCZ</sub>	Power Supply Current			35	55	mA	Max	V <sub>O</sub> = HIGH Z	

## **AC Electrical Characteristics**

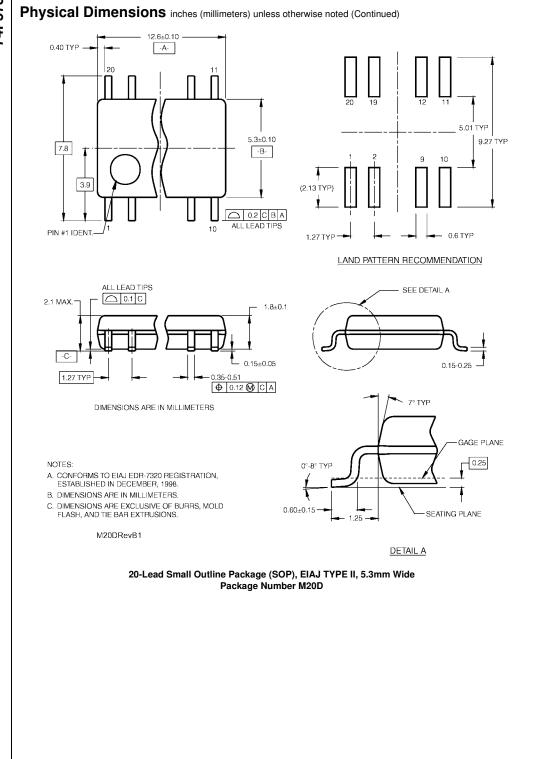
	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units
Symbol									
		Min	Тур	Max	Min	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay	3.0	5.3	7.0	3.0	9.0	3.0	8.0	ns
t <sub>PHL</sub>	D <sub>n</sub> to O <sub>n</sub>	2.0	3.7	6.0	2.0	7.0	2.0	6.5	
t <sub>PLH</sub>	Propagation Delay	5.0	9.0	11.0	5.0	13.5	5.0	12.0	20
t <sub>PHL</sub>	LE to O <sub>n</sub>	3.0	5.2	7.0	3.0	7.5	3.0	7.0	ns
t <sub>PZH</sub>	Output Enable Time	2.0	5.0	8.0	2.0	10.0	2.0	9.0	
t <sub>PZL</sub>		2.0	5.6	8.5	2.0	10.0	2.0	9.5	ns
t <sub>PHZ</sub>	Output Disable Time	1.5	4.5	5.5	1.5	7.0	1.5	6.5	115
t <sub>PLZ</sub>		1.5	3.8	5.5	1.5	5.5	1.5	5.5	

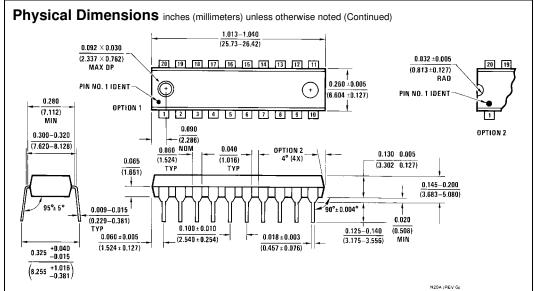
## **AC Operating Requirements**

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C$ to $+125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$		Units
		Min	Max	Min	Max	Min	Max	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	2.0		2.0		2.0		
$t_S(L)$	D <sub>n</sub> to LE	2.0		2.0		2.0		
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	3.0		3.0		3.0		ns
$t_H(L)$	D <sub>n</sub> to LE	3.5		4.0		3.5		
t <sub>W</sub> (H)	LE Pulse Width, HIGH	4.0		4.0		4.0		ns



20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M20B





20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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